Sheet 1 of 1

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO.

APPLICATION NO.

IT AND TRADEMARK OFFICE 1614.1104

FIRST NAMED INVENTOR

FILING DATE

Hideo MIYAKE et al.

December 15, 2000

GROUP ART UNIT

(Use several sheets if necessary)

LIST OF REFERENCES CITED BY APPLICANT

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Sheet 1 of 1 ATTORNEY DOCKET NO. FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE 09/736,357 1614.1104 FIRST NAMED INVENTOR LIST OF REFERENCES CITED BY APPLICANT Hideo MIYAKE et al. FILING DATE GROUP ART UNIT (Use several sheets if necessary) December 15, 2000 2183 **U.S. PATENT DOCUMENTS** *EXAMINER DOCUMENT SUB-**FILING CLASS** DATE INITIAL **CLASS** NO. DATE NAME AA 5,758,051 05/1998 Moreno et al. AB 5,694,577 12/1997 Kiyohara et al. RECEIVED AC AD MAR 1 7 2003 ΑE Technology Center 2100 ĀF FOREIGN PATENT DOCUMENTS SUB-**TRANSLATION** DOCUMENT **CLASS** YES NO NO. COUNTRY **CLASS** DATE AG 2000-222207 08/2000 abs Japan AH ΑI AJ AK AL OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) AN

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